



PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Mutsumi KIMURA

Application No.: 10/615,014

Filed: July 9, 2003

Docket No.: 116029

For: THIN-FILM TRANSISTOR, SWITCHING CIRCUIT, ACTIVE ELEMENT SUBSTRATE, ELECTRO-OPTICAL DEVICE, ELECTRONIC APPARATUS, THERMAL HEAD, DROPLET EJECTING HEAD, PRINTER, AND THIN-FILM-TRANSISTOR DRIVING AND LIGHT-EMITTING DISPLAY DEVICE

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- ☒ 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- ☒ 2. Relevance of the non-English language references 1-12 is discussed in the present specification.

Respectfully submitted,

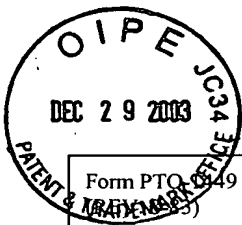

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<p style="text-align: center;">DEPOSIT ACCOUNT USE AUTHORIZATION Please grant any extension necessary for entry; Charge any fee due to our Deposit Account No. 15-0461</p>

Sheet 1 of 1

Form PTO-849 (Rev. 10-2002)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 116029		APPLICATION NO. 10/615,014	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT Mutsumi KIMURA			
				FILING DATE July 9, 2003			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
	1	Shimoda et al., "High Resolution Light Emitting Polymer Display Driven by Low Temperature Polysilicon Thin Film Transistor with Integrated Driver," Proceeding of Asia Display, pp. 217, 1998					
	2	Kimura et al., "Low-Temperature Polysilicon Thin-Film Transistor Driving with Integrated Driver for High-Resolution Light Emitting Polymer Display," IEEE Transactions on Electron Devices, Vol. 46, No. 12, pp. 2282-2288, December 1999					
	3	Shimoda et al., "Current Status and Future of Light-Emitting Polymer Display Driven by Poly-Si TFT," SID 99 Digest, pp.372-375, 1999					
	4	Kimura et al., "TFT-LEPD with Image Uniformity by Area Ratio Gray Scale," Proceeding of Euro. Display, pp. 71-74,					
	5	Kimura et al., "Low-Temperature Poly-Si TFT Driven Light-Emitting-Polymer Displays and Digital Gray Scale for Uniformity, " Proceeding of IDW, pp. 171-174, 1999					
	6	Tam et al., "Polysilicon TFT Drivers for Light Emitting Polymer Displays," IDW, pp. 175-178, 1999					
	7	Kimura et al., "An area-ratio gray-scale method to achieve image uniformity in TFT-LEPDs," Journal of the SID 8/2, pp. 93-97, 2000					
	8	Kimura et al., "Low-Temperature Poly-Si TFT Display using Light-Emitting-Polymer," AM-LCD, pp. 245-248, 2000					
	9	Tam et al., "Improved Polysilicon TFT Drivers for Light Emitting Polymer Displays," IDW, pp. 243-246, 2000					
	10	Inoue et al., "Investigation of the Relationship between Hot-Carrier Degradation and Kink Effect in Low-Temperature Poly-Si TFTs," SID Digest, pp. 452-455, 1999					
	11	Uraoka et al., "Hot Carrier Effects in Low-Temperature poly-Si p-ch TFTs under Dynamic Stress," AM-LCD, pp. 179-182, 2001					
	12	Ohno et al., "Device Simulation of Reliability in Low Temperature Poly-Si TFTs," Technical Report of IEICE, pp. 43-49, 2000					
EXAMINER					DATE CONSIDERED		
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Date: December 29, 2003